


<b>Search Notes</b>  	<b>Application/Control No.</b>  10567790	<b>Applicant(s)/Patent Under Reexamination</b>  NAGOH ET AL.
	<b>Examiner</b>  MICHAEL M BERNSHTEYN	<b>Art Unit</b>  1796

SEARCHED			
Class	Subclass	Date	Examiner
526	319	03/23/2010	MB
525	330.3, 7.2, 326.5	03/23/2010	MB
522	77, 172, 170	03/23/2010	MB

SEARCH NOTES		
Search Notes	Date	Examiner
EAST (USPAT, JPO, EPO, DERWENT, PREGRA NT)	03/23/2010	MB
PALM, eDAN, Inventors and Assignee search update	03/23/2010	MB
NPL	03/23/2010	MB

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
526	319	03/23/2010	MB
525	330.3, 7.2	03/23/2010	MB

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